UDC 622.774

A.A. LYSENKO, I.K. MLADETSKIY, Dr T. Sc, P.I. PILOV, Dr T. Sc (Ukraine, Dnipropetrovs'k, National Mining University)

# DETERMINATION OF REQUIRED MEASUREMENT ACCURACY OF PARAMETERS OF TECHNOLOGICAL PROCESS ON VOLNOGORSK MINING AND SMELTING COMPLEX

On basis of dispersion technical parameter definition in dressing technology with the help of dispersion specter exchange of initial mineral flow, the demands for accuracy of measure devise of these parameters are shown.

As is known, the measurement of parameters of quality of currents of concentration processes is made with certain inaccuracy. The less is inaccuracy (the bigger is accuracy), the more expensive is measuring process. The testing of great number of parameters for controlling of their values is made in processing line of concentration. Some parameters are rather sensitive to changes of technological regulations or concentration signs and the others are not sensitive. Obviously, depending on sensibility of the process different accuracy of measurement must be applied.

Commonly, the highly sensitive processes have wider allowable limits of change comparing with the low-sensitive. For the low-sensitive processes small deviations are significant and therefore the accuracy of measurement of their parameters must be high.

The parameters themselves can be measured more or less accurately depending on the value of mineral product and the purpose of information about it.

So for the management of process when only direction of change is important it is possible to carry out measurement with poor accuracy. It is more accurate for calculation with consumers of concentrates. Thus, the intermediate products can be measured more roughly and the concentrate more accurately.

Let's introduce the concept of sensibility and inaccuracy of technological process.

If, as a result of measurement of technological index, the deviation of index of quality by the value  $\Delta X_{\Pi}$  occurred with the initial value of the index of quality  $X_{\Pi}$ , the value

$$\delta = \frac{\Delta \tilde{O}_{\tilde{I}}}{\tilde{O}_{\tilde{I}}}$$

will determine the accuracy of process

Dressing of minerals, 2013. – №. 54(95)

$$\tau = \frac{1}{|\delta|} = \frac{X}{\Delta X}.$$

If as a result of measurement of technological index the inaccuracy  $\sigma_{II}$  is allowed, with the initial value of the index of quality  $X_{II}$ , the value

$$\delta = \frac{\sigma_H}{X_H}.$$

will determine the accuracy of process

$$\tau = \frac{1}{|\delta|} = \frac{X_{\boldsymbol{H}}}{\sigma_{\boldsymbol{H}}}.$$

Thereby, the accuracy of measurement  $\sigma_{U}$  of the value must be higher than the accuracy of technological process  $\sigma_{II}$ , i.e.

$$\sigma_{H} < \sigma_{\Pi}$$
 .

Herewith, the value of  $X_{II}$  with inaccuracy  $\sigma_{II}$  must match the value of technological process  $X_{II}$ :

$$X_{II} \approx X_{II}$$
.

The inequality can be of the small or considerable difference.

Performance of technological process must be used for objective choice of the rate of inequality. Let's use the sensibility index here. The change of qualitative parameters at changing of operating parameters or parameters of concentration signs determines the sensibility. For this purpose we researched the change of quality of intermediate products to the change of the said parameters. The research was performed numerically using the determined model of technological process. The scheme of concentration of alluvial deposits of Volnogorsk Mining and Smelting Complex was taken as technological process. The research results made up the table where mathematical model was verified for adequacy and the assessments of derivatives were obtained for all the points of technology and for the change of considerable size so we deem unnecessary to put it in this article, so let's pitch upon some generalizing parameters of it.

Since at operation of technology all parameters of modes and concentration signs act simultaneously, we chose the highest derivatives in terms of the absolute value among research results. Expectedly, no higher values of derivatives were observed, since it would lead to instable conditions of technology. We can assume that the limits of change of derivatives:

$$-2,0 \le \frac{d\beta}{dx_i} \le 2,0.$$

At an average the derivatives are of approximate value  $\frac{d\beta}{dx_i} = 0.5$ .

The higher is the value of derivative, the bigger is the change of quality at small changes of modes and the more inaccurate can be the measuring assessment of this quality. And vice versa: the less is the change of quality at small changes of modes, the more accurate must be the measuring assessment of this quality.

To select the required measurement accuracy the binding to some stable parameters of technological process must be provided. It can be the average value of the mode, median etc. The research of technological process using the Monte Carlo method showed that distribution of quality parameters of industrial products at all points of the system is even, so we use its average value  $-\overline{X}\Pi$ . Then the expression binding the inaccuracies of technology and measurement can be represented as follows:

$$\frac{X_{H}}{\sigma_{H}} - \frac{X_{\Pi}}{\sigma_{\Pi}} = \frac{\kappa}{f^{1}}$$

where  $\kappa$  – coefficient matching the dimensionalities.

We can represent  $X_{II} = X_{II} + \sigma_{II}$ . Then:

$$\frac{X_{\Pi} + \sigma_{H}}{\sigma_{H}} - \frac{X_{\Pi}}{\sigma_{\Pi}} = \frac{\kappa}{f^{1}},$$

or

$$X_{\Pi}(\frac{1}{\sigma_{\Pi}} - \frac{1}{\sigma_{\Pi}}) = \frac{\kappa}{f^1} - 1.$$

As a result we have

$$\sigma_{II} = \frac{\sigma_{II}}{1 + \frac{\sigma_{II}}{X_{II}}(\frac{\kappa}{f^1} - 1)}.$$

So, when the ratio of the average quadratic deviation to the average value of technological process is quite small, the inaccuracy of measurement can be equal to inaccuracy of technological process, i.e. the change of parameters of concentrates can be produced with the inaccuracy, that is in the technological process. The change of values at the beginning of technology must be produced with the accuracy of bigger

### Dressing of minerals, 2013. – №. 54(95)

accuracy of technological process. Meanwhile, if derivative of technological index is rather small, the inaccuracy of measurement must be decreased considerably.

Concentration processes have the big share of random component and therefore are polyharmonical, where nonrandom component is substantially suppressed by nuisances. To highlight such nonrandom component the spectral decomposition of random process is used. The spectral function is calculated using the correlation under one and rather long realization of stationary random process [1]

$$S(\omega) = \frac{1}{2\Pi} \int_0^\infty K_{xx}(\tau) \cos(\omega\tau) d\tau \tag{1}$$

where:  $K_{xx}(\tau)$  – correlation function of random process;  $\omega$  – frequency.

From there, specifying the frequency  $\omega$  and making the integration (1) we can find the value of spectral function. Specifying the set of values  $\omega$  we can determine the whole function  $S(\omega)$ .

Any dynamic object transforms the spectrum of input process  $S_x(\omega)$  into the spectrum of output process  $S_y(\omega)$  according to its frequency characteristic  $\Phi(j\omega)$  (j= $\sqrt{-1}$ ), according to the expression [2]

$$S_{v}(\omega) = |\phi(j\omega)|^{2} S_{x}(\omega).$$
<sup>(2)</sup>

So, if the frequency characteristic of processing line is known, finding of square of its module we can determine the spectrum of the output process. Since the dispersion of process  $D_x$  is

$$D_x = \int_0^\infty S(\omega) \, d\omega, \tag{3}$$

the dispersion of output process will be also found.

Frequency characteristic is on the basis of transfer function of devices according to the rules of transformation of structural schemes [5].

The value  $X_{\Pi}$  is determined on the basis of separation characteristics of devices by making of the system of balance equations for each product

$$\begin{split} \beta_{11}\gamma_1 + \beta_{12}\gamma_2 + \beta_{13}\gamma_3 + \ldots + \beta_{1n}\gamma_n &= \alpha_1 \\ \beta_{21}\gamma_1 + \beta_{22}\gamma_2 + \beta_{23}\gamma_3 + \ldots + \beta_{2n}\gamma_n &= \alpha_2 \\ \vdots \\ \beta_{m1}\gamma_1 + \beta_{m2}\gamma_2 + \beta_{m3}\gamma_3 + \ldots + \beta_{mn}\gamma_n &= \alpha_m \\ \gamma_1 + \gamma_2 + \gamma_3 + \ldots + \gamma_n &= 1 \end{split}$$

Here is n – quantity of concentration; m – quantity of components.

So, for all processing line of production of disthene the system of equalities has the 147<sup>th</sup> order. Comparing of the results of solution with the results of testing gave

**Dressing of minerals, 2013.** – № 54(95)

the maximal divergence of not more than 5%. On this ground the decision on adequacy of the method of calculation of output parameters of concentration – output and content of valuable mineral was taken.

Using such modeling the derivatives for quality parameters of intermediate products and concentrates were obtained:

$$\frac{\partial \beta_i}{\partial \alpha_j} \approx \frac{\beta_{i \max} - \beta_{i \min}}{\alpha_{j \max} - \alpha_{j \min}} = f^1.$$

In that way, all variables for determination of required inaccuracy of measurement of intermediate products and concentrates are obtained.

Using this method for technology of concentration of disthene that is produced on Volnogorsk Mining and Smelting Complex (concentration scheme on Figure 1 and 2) the dispersions along the processing line are obtained (table 1), where Di number of point of processing line is specified and the lower columns specify the values of dispersions at corresponding points.

As follows from the table 1 the dispersions of quality parameters along the processing line decrease and the bigger is the number of devices, the more considerable is this decrease. Beginning from the  $17^{\text{th}}$  point, the required accuracy of control of technological parameters increase appreciably and must have the order  $10^{-4}$ - $10^{-5}$  %. It is problematically to reach such accuracy at single measurement, therefore the measurement volume V must be increased which, as is known [4], depends on the ratio of the accuracy of measuring device C to the required accuracy  $\varepsilon$  that is numerically represented as ratio of average quadratic deviations:

$$V = \left(\frac{3C}{\varepsilon}\right)^3 d^3.$$

Table 1

Dispersion							
D1	D2	D3	D4	D5	D6	D7	D8
0,92	0	0,934	3,237*10-5	0,46	1,181	0,703	0,081
D9	D10	D11	D12	D13	D14	D15	D16
0,087	0,252	0,232	0,017	0,058	0,014	2,544*10-3	7,965*10-4
D17	D18	D19	D20	D21	D22	D23	D24
1,721*10-7	0	3,619*10-3	0	3,076*10-4	0	7,116*10-5	0
D25	D26	D27	D28	D29	D30	D31	D32
1,402*10-5	2,584*10-6	2,145*10-7	2,512*10-6	1,39*10-9	1,908*10-9	5,528*10-12	3,384*10-12

The value dispersion of technological results into scheme disthen dressing product



Fig. 1. Scheme of dressing disthen chapter 1





Dressing of minerals, 2013. – № 54(95)

#### Reference

1.Вентцель Е.С. Теория вероятностей. – М.: Наука, 1969. – 576 с.

2.Росин М.Ф. Статистическая динамика и теория эффективности систем управления. – М.: Машиностроение, 1981. – 312 с.

З.Бесекерский В.А. Попов Е.П. Теория систем автоматического регулирования. – М.: Наука, 1963. – 517 с.

4. Козин В.З. Опробование и контроль процессов обогащения полезных ископаемых. – М.: Недра, 1986. – 374 с.

© Lysenko A.A., Mladetskiy I.K., Pilov P.I., 2013

Надійшла до редколегії 10.09.2013 р. Рекомендовано до публікації д.т.н. О.Д. Полуляхом